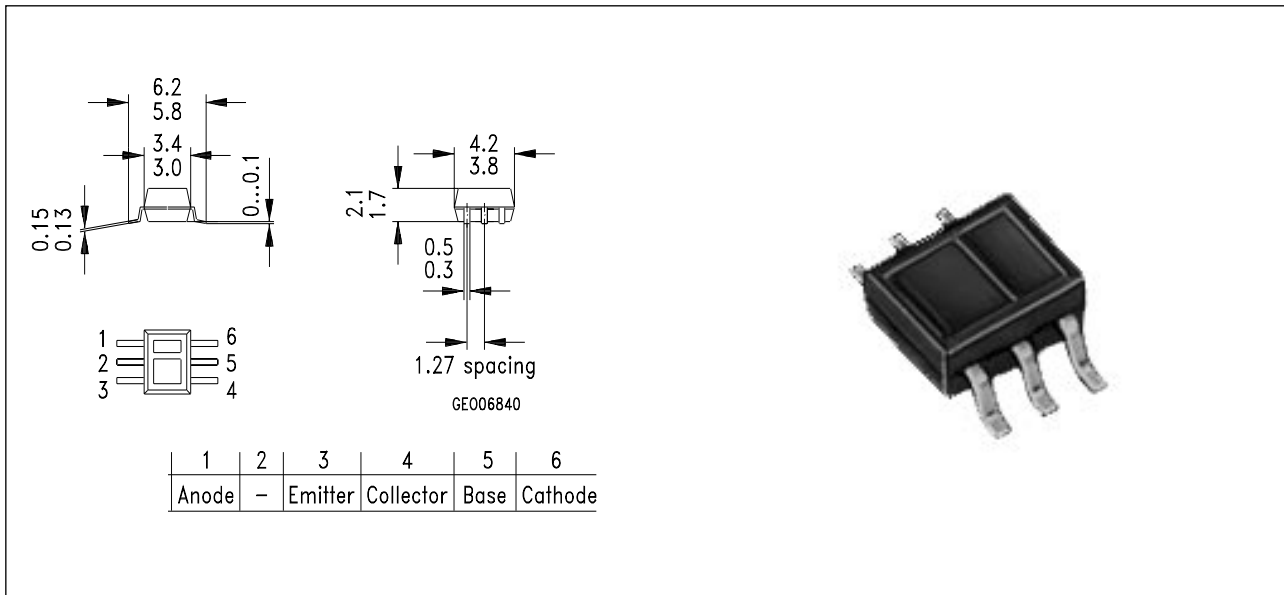


Reflexlichtschranke im SMT-Gehäuse Light Reflection Switch in SMT Package

SFH 9101

Vorläufige Daten

Preliminary Data



Maße in mm, wenn nicht anders angegeben/Dimensions in mm, unless otherwise specified.

Wesentliche Merkmale

- Reflexlichtschranke für 1 mm bis 5 mm Arbeitsabstand
- IR-GaAs-Lumineszenzdiode: Sender
- Si-NPN-Fototransistor: Empfänger
- Tageslichtsperrfilter
- Hoher Kollektor-Emitter-Strom
0.25 ... ≥ 1.0 mA
- Geringe Sättigungsspannung
- Kein Übersprechen
- Sender und Empfänger galvanisch getrennt
- Basisanschluß herausgeführt

Anwendungen

- Positionsmelder
- Endabschalter
- Drehzahlüberwachung, -regelung
- Bewegungssensor

Features

- Light reflection switch for 1 mm to 5 mm operating distance
- IR-GaAs-emitter
- Silicon NPN phototransistor detector
- Daylight filter against undesired light effects
- High collector-emitter current
0.25 ... ≥ 1.0 mA
- Low saturation voltage
- No cross-talk
- Emitter and detector electrically isolated
- Base connection brought out

Applications

- Position reporting
- End position switch
- Speed monitoring and regulating
- Motion transmitter

Typ Type	Bestellnummer Ordering Code
SFH 9101	Q62702-P474

Grenzwerte Maximum Ratings

Bezeichnung Description	Symbol Symbol	Wert Value	Einheit Unit
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Sender (IR-GaAs-Diode) Emitter (IR-GaAs Diode)

Sperrspannung Reverse voltage	V_R	6	V
Vorwärtsgleichstrom Forward current	I_F	50	mA
Vorwärtsstoßstrom, ($t_p \leq 10 \mu s$) Surge current	I_{FSM}	1.5	A
Verlustleistung Power dissipation	P_{tot}	80	mW

Empfänger (Si-Fototransistor) Detector (silicon phototransistor)

Kollektor-Emitter-Sperrspannung Collector-emitter voltage	V_{CEO}	30	V
Emitter-Kollektor-Sperrspannung Emitter-collector voltage	V_{ECO}	7	
Kollektorstrom Collector current	I_C	10	mA
Verlustleistung Total power dissipation	P_{tot}	100	mW

Reflexlichtschranke Light reflection switch

Lagertemperatur Storage temperature range	T_{stg}	- 40 ... + 85	°C
Umgebungstemperatur Ambient temperature range	T_A	- 40 ... + 85	
Sperrschichttemperatur Junction temperature range	T_j	100	

Löthinweise Soldering conditions

Bauform Type	Tauch-, Schwall- und Schleppplötung Dip, wave and drag soldering			Reflowlötung Reflow soldering	
	Lötbad- temperatur Temperature of the soldering bath	Maximal zulässige Lötzeit Max. perm. soldering time	Abstand Lötstelle Gehäuse Distance between solder joint and case	Lötzonen- temperatur Temperature of soldering zone	Maximale Durchlaufzeit Max. transit time
SFH 9101	260 °C	8 s	–	260 °C : 215 °C Vorheizung Preheating: 150 °C	10 s : 40 s approx. 1 min.

Verarbeitungshinweise für SMT-Bauelemente beachten!
Please observe the handling guidelines for SMT devices!

Kennwerte ($T_A = 25\text{ °C}$) Characteristics

Bezeichnung Description	Symbol Symbol	Wert Value	Einheit Unit
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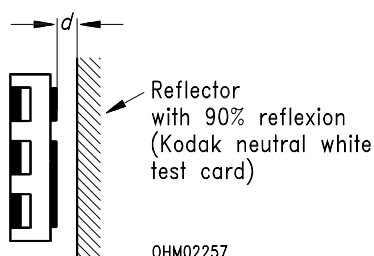
Sender (IR-GaAs-Diode) Emitter (IR-GaAs diode)

Durchlaßspannung Forward voltage $I_F = 50\text{ mA}$	V_F	1.25 (≤ 1.65)	V
Durchbruchspannung Breakdown voltage $I_R = 10\text{ }\mu\text{A}$	V_{BR}	≥ 6	V
Sperrstrom Reverse current $V_R = 6\text{ V}$	I_R	0.01 (≤ 10)	μA
Kapazität Capacitance $V_R = 0\text{ V}, f = 1\text{ MHz}$	C_O	25	pF
Wärmewiderstand ¹⁾ Thermal resistance ¹⁾	R_{thJA}	500	K/W

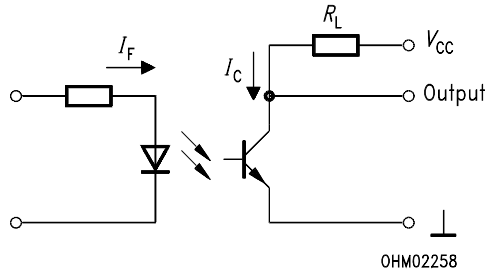
Kennwerte ($T_A = 25\text{ °C}$)

Characteristics

Bezeichnung Description	Symbol Symbol	Wert Value	Einheit Unit
Empfänger (Si-Fototransistor) Detector (silicon phototransistor)			
Kapazität Capacitance $V_{CE} = 5\text{ V}$, $f = 1\text{ MHz}$	C_{CE}	11	pF
Kollektor-Emitter-Reststrom Collector-emitter leakage current $V_{CE} = 10\text{ V}$	I_{CEO}	20 (≤ 200)	nA
Fotostrom (Fremdlichtempfindlichkeit) Photocurrent (outside light density) $V_{CE} = 5\text{ V}$, $E_V = 1000\text{ Lx}$	I_P	3.5	mA
Wärmewiderstand ¹⁾ Thermal resistance ¹⁾	R_{thJA}	500	K/W
Reflexlichtschranke Light reflection switch			
Kollektor-Emitterstrom Collector-emitter current Kodak neutral white test card, 90 % Reflexion $I_F = 10\text{ mA}$; $V_{CE} = 5\text{ V}$; $d = 1\text{ mm}$	$I_{CE\text{ min.}}$ $I_{CE\text{ typ.}}$	0.25 0.70	mA mA
Kollektor-Emitter-Sättigungsspannung Collector-emitter-saturation voltage Kodak neutral white test card, 90 % Reflexion $I_F = 10\text{ mA}$; $d = 1\text{ mm}$; $I_C = 85\text{ }\mu\text{A}$	$V_{CE\text{ sat}}$	0.2 (≤ 0.6)	V

1) Montage auf PC-Board mit $>5\text{ mm}^2$ Padgröße1) Mounting on pcb with $>5\text{ mm}^2$ pad size

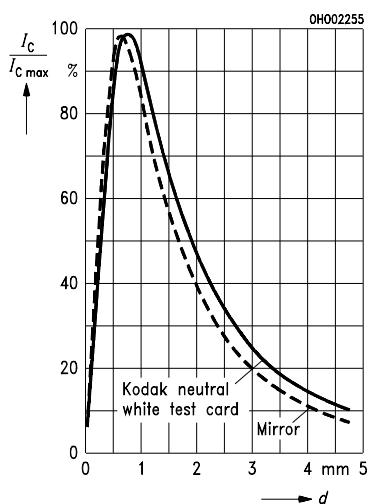
Schaltzeiten ($T_A = 25\text{ }^{\circ}\text{C}$, $V_{CC} = 5\text{ V}$, $I_C = 1\text{ mA}^{1)}$, $R_L = 1\text{ k}\Omega$)
Switching times



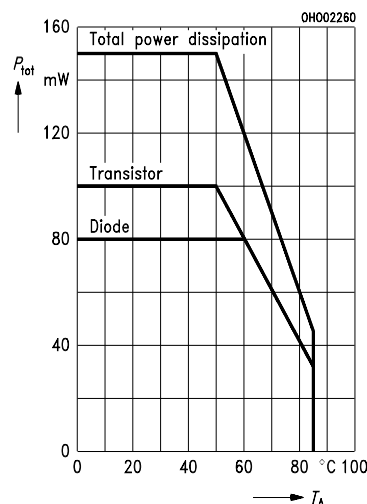
Bezeichnung Description	Symbol Symbol	Wert Value	Einheit Unit
Einschaltzeit Turn-on time	t_{ein} t_{on}	65	μs
Anstiegszeit Rise time	t_r	50	μs
Ausschaltzeit Turn-off time	t_{aus} t_{off}	55	μs
Abfallzeit Fall time	t_f	50	μs

- 1) I_C eingestellt über den Durchlaßstrom der Sendediode, den Reflexionsgrad und den Abstand des Reflektors vom Bauteil (d)
- 1) I_C as a function of the forward current of the emitting diode, the degree of reflection and the distance between reflector and component (d)

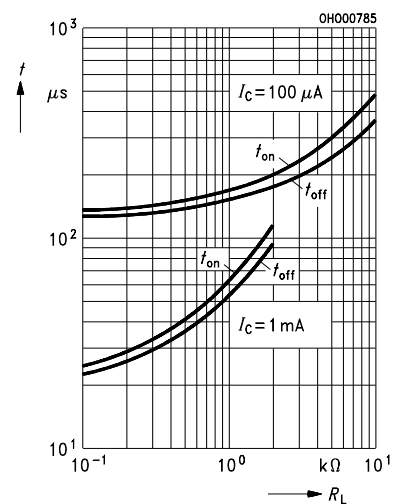
Collector current $\frac{I_C}{I_{C\text{max}}} = f(d)$



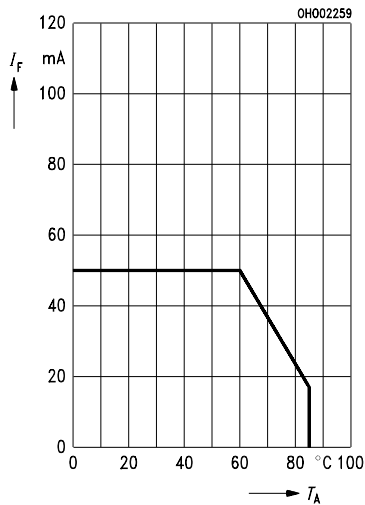
Permissible power dissipation for diode and transistor $P_{\text{tot}} = f(T_A)$



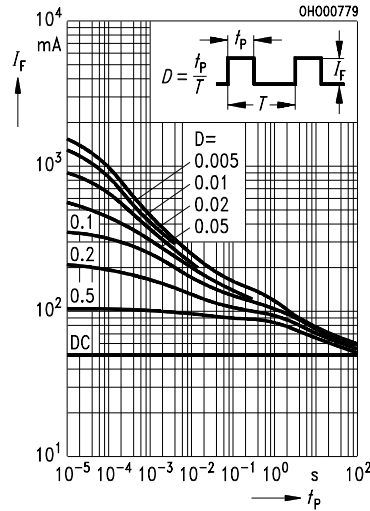
Switching characteristics $t = f(R_L)$
 $T_A = 25\text{ }^{\circ}\text{C}$, $I_F = 10\text{ mA}$



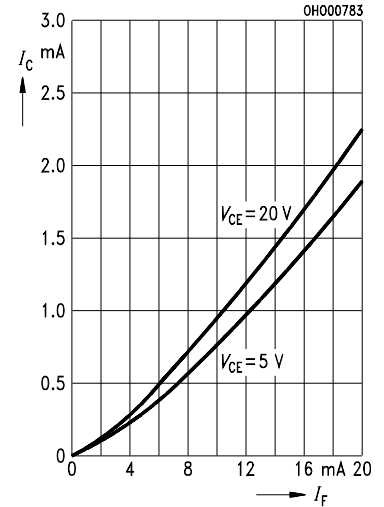
Max. permissible forward current
 $I_F = f(T_A)$



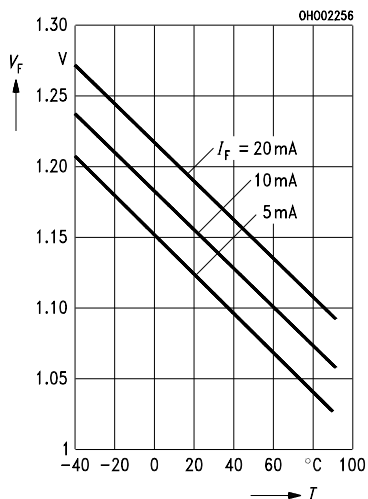
Permissible pulse handling capability
 $I_F = f(t_p)$, $D = \text{Parameter}$, $T_A = 25^\circ\text{C}$



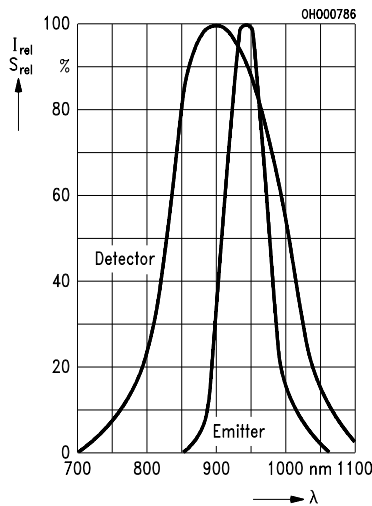
Collector current $I_C = f(I_F)$, spacing d to reflector = 1 mm, 90% reflection



Forward voltage (typ.) of the diode
 $V_F = f(T)$

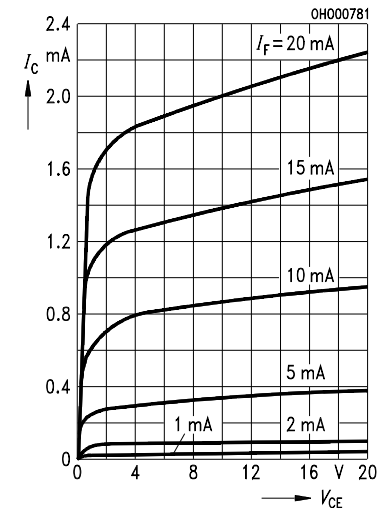


Relative spectral emission of emitter (GaAs) $I_{\text{rel}} = f(\lambda)$ and detector (Si) $S_{\text{rel}} = f(\lambda)$



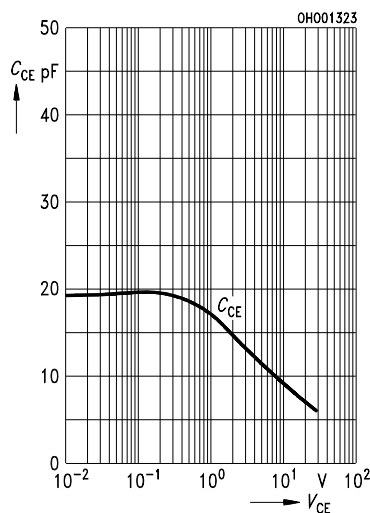
Output characteristics

$I_C = f(V_{CE})$, spacing to reflector: $d = 1 \text{ mm}$, 90% reflection, $T_A = 25^\circ\text{C}$



Transistor capacitance (typ.)

$C_{CE} = f(V_{CE})$, $T_A = 25^\circ\text{C}$, $f = 1 \text{ MHz}$



Output characteristics (typ.)

$I_C = f(V_{CE})$, spacing to reflector: $d = 1 \text{ mm}$, 90% reflection, $T_A = 25^\circ\text{C}$

